



ZL MOSFET

ZL010N08GA

Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	I_D
100V	8.5mΩ@10V	65A
	11mΩ@4.5V	

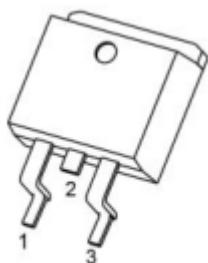
Feature

- Fast Switching
- Low Gate Charge and Rdson
- Advanced Split Gate Trench Technology
- 100% Single Pulse avalanche energy Test

Application

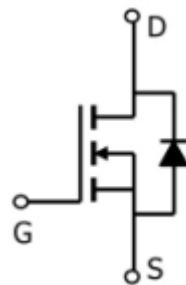
- Power switching application
- PWM Application
- DC-DC Converter

Package

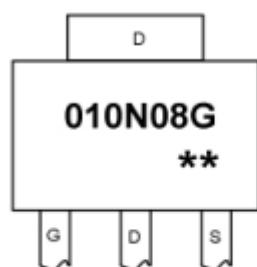


TO-263(1:G 2:D 3:S)

Circuit diagram



Marking



010N08G =Device Code
** =Week Code

Absolute maximum ratings

($T_a=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ($T_c=25^\circ\text{C}$)	I_D	65	A
Pulsed Drain Current ²	I_{DM}	260	A
Single Pulse Avalanche Energy ³	E_{AS}	156	mJ
Power Dissipation ⁴ ($T_c=25^\circ\text{C}$)	P_D	90	W
Thermal Resistance Junction-Case ¹	$R_{\theta JC}$	1.38	$^\circ\text{C}/\text{W}$
Storage Temperature Range	T_{STG}	-55~ +150	$^\circ\text{C}$
Operating Junction Temperature Range	T_J	-55~ +150	$^\circ\text{C}$



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Electrical characteristics

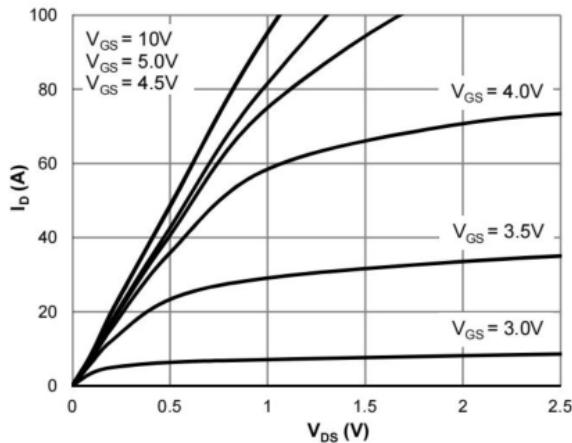
(T_A=25°C, unless otherwise noted)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
Drain-source breakdown voltage	BV _{DSS}	V _{GS} = 0V, I _D = 250μA	100			V
Drain-Source Leakage Current	I _{DSS}	V _{DS} = 80V, V _{GS} = 0V, T _J = 25°C			1	uA
Gate-Source Leakage Current	I _{GSS}	V _{GS} = ±20V, V _{DS} = 0V			±100	uA
Gate threshold voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	1.2	1.9	2.5	V
Static Drain-Source on-Resistance	R _{DS(on)}	V _{GS} = 10V, I _D = 20A		8.5	12	mΩ
		V _{GS} = 4.5V, I _D = 15A		11	15	
Dynamic characteristics						
Input Capacitance	C _{iss}	V _{DS} = 50V, V _{GS} = 0V, f = 1MHz		1635		pF
Output Capacitance	C _{oss}			339		
Reverse Transfer Capacitance	C _{rss}			22		
Switching Characteristics						
Total Gate Charge (4.5V)	Q _g	V _{DS} = 50V, V _{GS} = 10V, I _D = 20A		14		nC
Gate-Source Charge	Q _{gs}			5		
Gate-Drain Charge	Q _{gd}			7		
Turn-On Delay Time	T _{d(on)}	V _{DD} = 50V, V _{GS} = 10V, R _L = 2.5Ω, R _G = 6Ω		8		nS
Rise Time	T _r			16		
Turn-Off Delay Time	T _{d(off)}			31		
Fall Time	T _f			27		
Drain-Source Diode Characteristics						
Diode forward voltage ²	V _{SD}	V _{GS} = 0V, I _S = 1A, T _J = 25°C			1.2	V

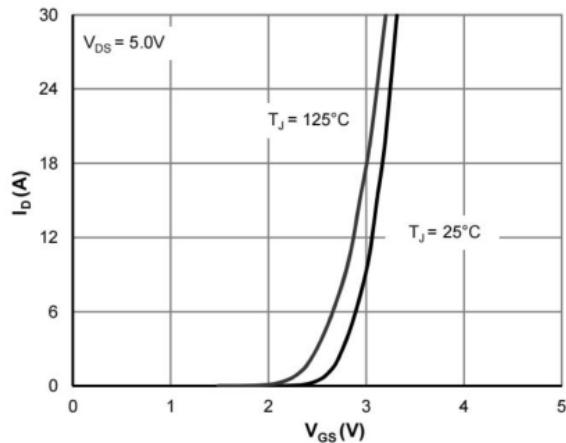
Notes:

- The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%
- The EAS data shows Max. rating. The test condition is V_{DD} = 50V, V_{GS} = 10V, L = 0.5mH, R_G = 25Ω
- The power dissipation is limited by 150°C junction temperature

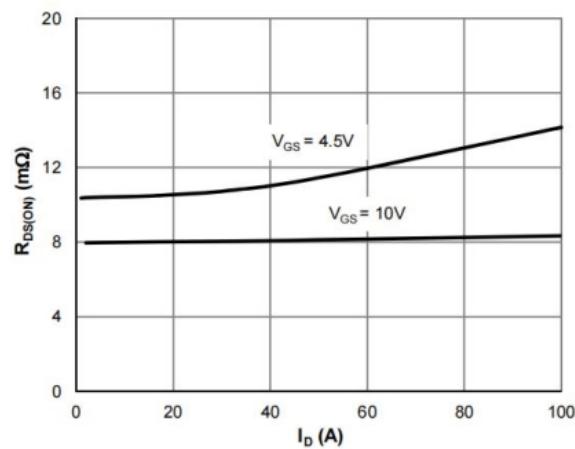
Typical Characteristics



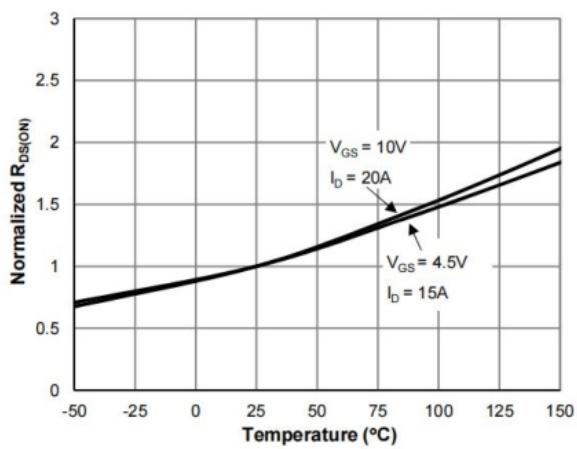
Typical Output Characteristics



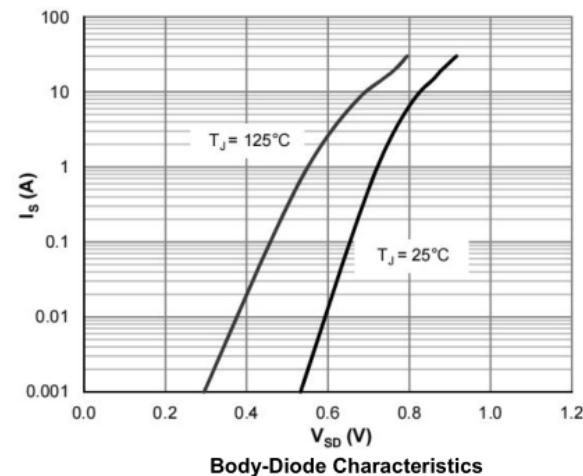
Transfer Characteristics



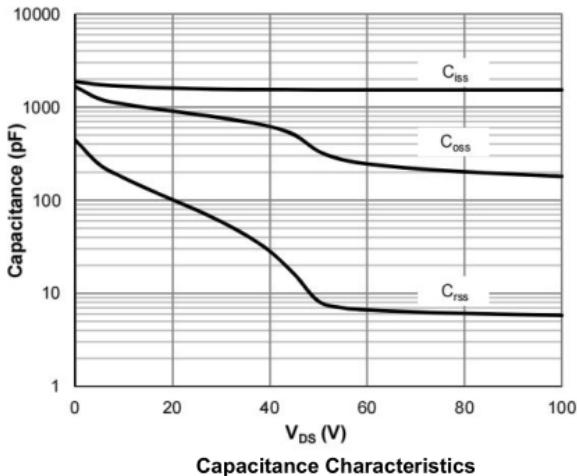
On-Resistance vs. Drain Current



On-Resistance vs. Junction Temperature



Body-Diode Characteristics

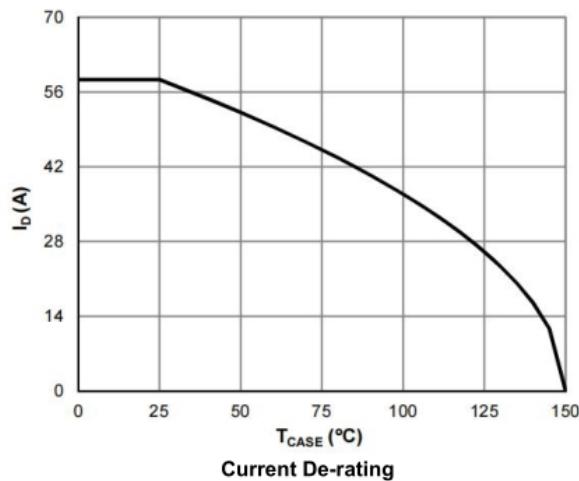


Capacitance Characteristics

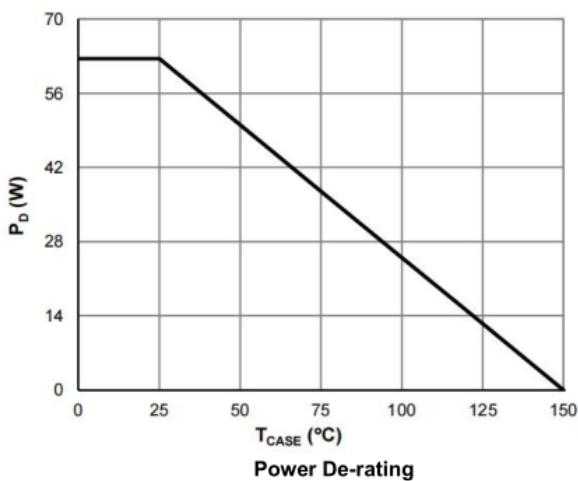


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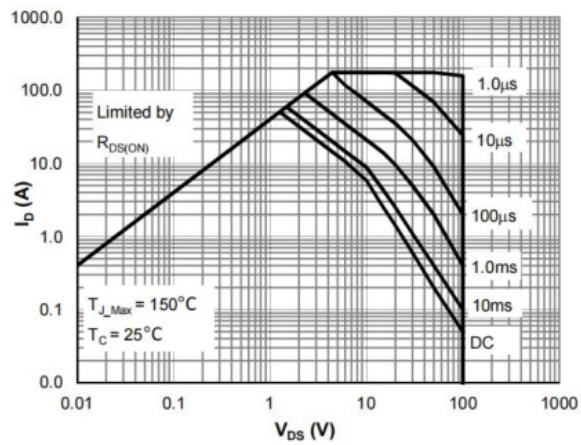
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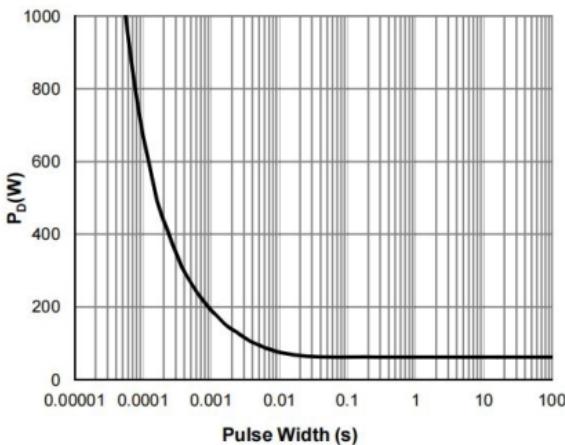
Current De-rating



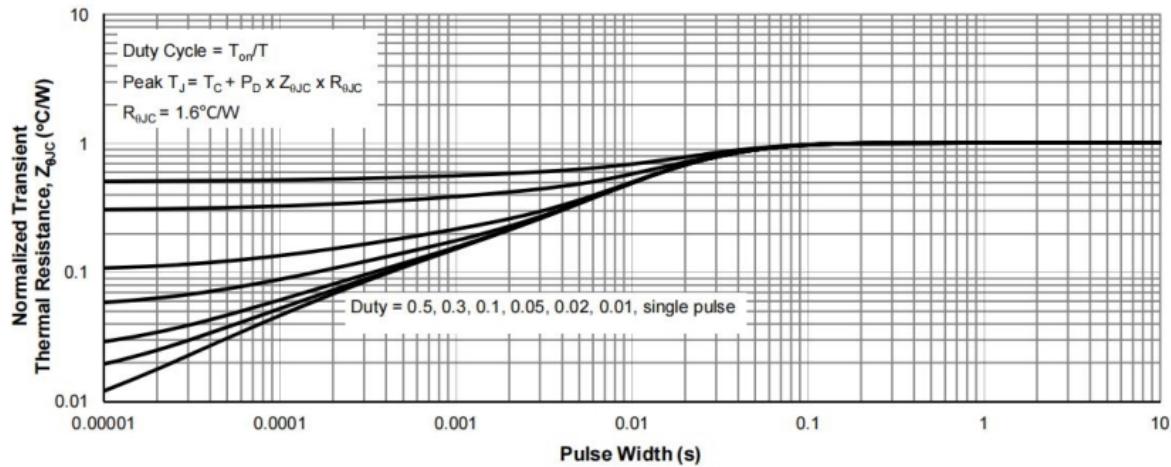
Power De-rating



Maximum Safe Operating Area

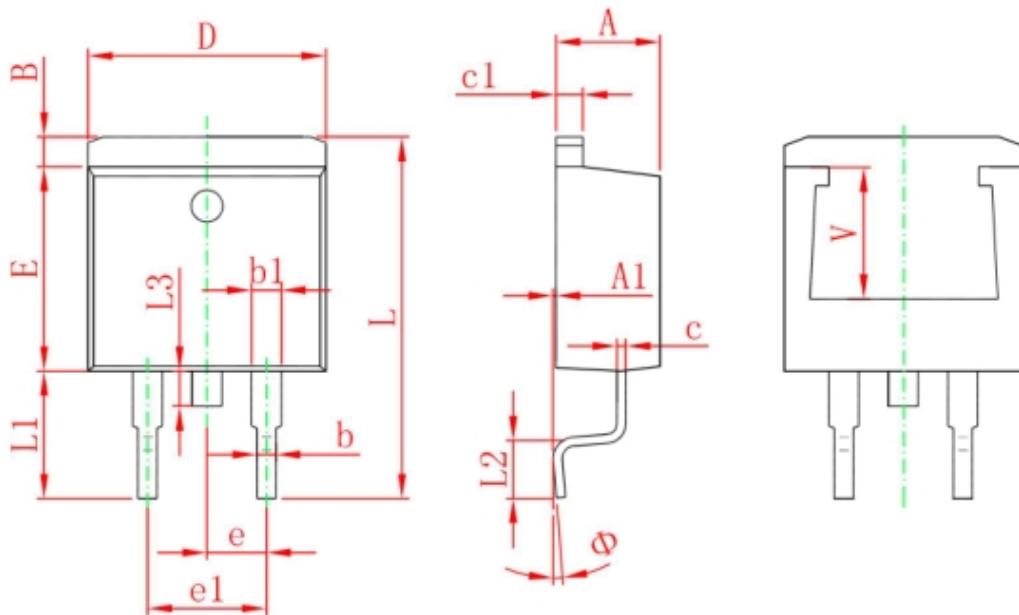


Single Pulse Power Rating, Junction-to-Case



Normalized Maximum Transient Thermal Impedance

TO-263 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.470	4.670	0.176	0.184
A1	0.000	0.150	0.000	0.006
B	1.120	1.420	0.044	0.056
b	0.710	0.910	0.028	0.036
b1	1.170	1.370	0.046	0.054
c	0.310	0.530	0.012	0.021
c1	1.170	1.370	0.046	0.054
D	10.010	10.310	0.394	0.406
E	8.500	8.900	0.335	0.350
e	2.540 TYP.		0.100 TYP.	
e1	4.980	5.180	0.196	0.204
L	14.940	15.500	0.588	0.610
L1	4.950	5.450	0.195	0.215
L2	2.340	2.740	0.092	0.108
L3	1.300	1.700	0.051	0.067
Φ	0°	8°	0°	8°
V	5.600 REF.		0.220 REF.	